

HiPerFRED[™] Epitaxial Diode ISOPLUS220[™]

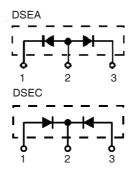
Electrically Isolated Back Surface

Preliminary Data Sheet

Symbol

RSM	RRM	RM IYPO		
V	V			
600	600	DSEA 59-06BC DSEC 59-06BC		

Conditions



Maximum Ratings

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I _{FRMS} ①	Lead current limit	45	А	
FAVM	$T_c = 105^{\circ}C$; rectangular, d = 0.5	30	A	
I _{FSM}	T_{vJ} = 45°C; t_p = 10 ms (50 Hz), sine	200	А	
E _{AS}	$T_{VJ} = 25^{\circ}C$; non-repetitive $I_{AS} = 1.3 A$; L = 180 µH	0.2	mJ	
I _{AR}	$V_A = 1.5 \cdot V_R$ typical; f = 10 kHz; repetitive	0.1	А	
T _{vJ}		-40+175	°C	
T _{VJM}		175	°C	
T _{stg}		-40+150	°C	
T _L	1.6 mm (0.063 in) from case for 10 s	260	°C	
P _{tot}	$T_c = 25^{\circ}C$	136	W	
VISOL	50/60 Hz RMS; $I_{ISOL} \leq 1 \text{ mA}$	2500	V~	
F _c	Mounting force	1165 / 2.515	N/Ib	
Weight	typical	2	g	

Symbol	Conditions	Charact typ.	haracteristic Values typ.		
I _R ⊘	$\begin{array}{ll} T_{VJ} = 25^{\circ}C & V_{R} = V_{RRM} \\ T_{VJ} = 150^{\circ}C & V_{R} = V_{RRM} \end{array}$		250 2	μA mA	
V _F ③	$I_F = 30 \text{ A};$ $T_{VJ} = 150^{\circ}\text{C}$ $T_{VJ} = 25^{\circ}\text{C}$		1.56 2.51	V V	
R _{thJC} R _{thCH}		0.6	1.1	K/W K/W	
t _{rr}	$I_F = 1 \text{ A}; -di/dt = 200 \text{ A}/\mu\text{s};$ $V_R = 30 \text{ V}; \text{ T}_{VJ} = 25^{\circ}\text{C}$	30		ns	
I _{RM}	$ \begin{array}{ll} V_{\text{R}} = 100 \; \text{V}; & \text{I}_{\text{F}} = 50 \; \text{A}; \; -\text{d}_{\text{F}}/\text{d}t = 100 \; \text{A}/\mu\text{s} \\ T_{\text{VJ}} = 100^{\circ}\text{C} \end{array} $	s 4		A	

Notes: Data given for T_{vJ} = 25°C and per diode unless otherwise specified

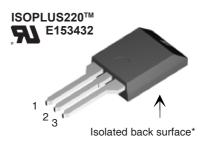
- ① Average current per diode may be limited by center lead RMS current limit when both diodes are conducting.
- ② Pulse test: pulse Width = 5 ms, Duty Cycle < 2.0 %</p>
- 3 Pulse test: pulse Width = 300 $\mu s,$ Duty Cycle < 2.0 %

IXYS reserves the right to change limits, test conditions and dimensions.

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DSEA 59-06BC DSEC 59-06BC

$I_{FAV} = 2x30 A$ $V_{RRM} = 600 V$ $t_{rr} = 35 ns$



Features

- Silicon chip on Direct-Copper-Bond substrate
- High power dissipation
- Isolated mounting surface
- 2500V electrical isolation
- Low cathode to tab capacitance (<15pF)
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low ${\rm I}_{\rm \tiny RM}{\rm -values}$
- Soft recovery behaviour
- Epoxy meets UL 94V-0

Applications

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating
- Uninterruptible power supplies (UPS)
- · Ultrasonic cleaners and welders

Advantages

- Avalanche voltage rated for reliable operation
- Soft reverse recovery for low EMI/RFI Low ${\rm I}_{\rm RM}$ reduces:
- Power dissipation within the diode
- Turn-on loss in the commutating switch

See DSEP 29-06B data sheet for characteristic curves

